

<b>Notice of References Cited</b>	Application/Control No. 10/692,285	Applicant(s)/Patent Under Reexamination LECRONE ET AL.	
	Examiner Emeka Ebirim	Art Unit 2166	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,742,792 A	04-1998	Yanai et al.	711/162
*	B	US-5,889,935 A	03-1999	Ofek et al.	714/6
*	C	US-6,052,797 A	04-2000	Ofek et al.	714/6
*	D	US-6,085,298 A	07-2000	Ohran, Richard	711/162
*	E	US-6,173,377 B1	01-2001	Yanai et al.	711/162
*	F	US-2001/0002480 A1	05-2001	DEKONING et al.	711/130
*	G	US-6,324,654 B1	11-2001	Wahl et al.	714/6
*	H	US-2001/0052058 A1	12-2001	OHRAN, RICHARD S.	711/161
*	I	US-6,397,307 B2	05-2002	Ohran, Richard S.	711/161
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.